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Observation of current whirlpools in graphene at room temperature

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Electron-electron interactions in high-mobility conductors can give rise to transport signatures resembling those described by classical hydrodynamics. Using a nanoscale scanning magnetometer, we image a striking hydrodynamic transport pattern – stationary current vortices – in a monolayer graphene device at room temperature. By measuring devices with increasing characteristic size, we observe the disappearance of the current vortex and thus verify a prediction of the hydrodynamic model. We further observe that vortex flow is present for both hole- and electron-dominated transport regimes, but disappears in the ambipolar regime. We attribute this effect to a reduction of the vorticity diffusion length near charge neutrality. Our work showcases the power of local imaging techniques for unveiling exotic mesoscopic transport phenomena.

Transport phenomena in mesoscopic devices are governed by the relative distance separating carrier scattering events compared to the characteristic device size L. In a non-interacting system, once the device size becomes smaller than the momentum-relaxing scattering length $l_{\rm mr}$ set by collision events with impurities and phonons ($L \ll l_{\rm mr}$), carriers move unimpeded until they are scattered off a device boundary. This ballistic regime is of great scientific interest and manifests itself, for example, in transverse magnetic focusing experiments [1] or through a quantized conductance in quantum point contacts [2].

In contrast, momentum-conserving collisions between carriers play a minor role in the transport of conventional metals, because they occur much less frequently than momentum-relaxing collisions [3, 4]. However, in materials where scattering events are scarce, such as encapsulated graphene and high-mobility Ga[AI]As heterostructures at intermediate temperatures, $l_{\rm mr}$ can approach or even surpass the carrier-carrier scattering length ($l_{\rm ee}$) for a finite temperature range. Consequently, in a device satisfying $l_{\rm ee} \ll L$, $l_{\rm mr}$, transport properties become dominated by carrier-carrier interactions. This regime, governed by the collective behavior of interacting carriers, can give rise to peculiar transport features that are unexpected when compared to traditional diffusive or ballistic transport, such as viscosity [5] or even turbulence [6]. Owing to the analogy to classical fluid flow, this transport regime is commonly referred to as the viscous or hydrodynamic regime.

Initial theoretical work on hydrodynamic electron transport predicted a decrease of the resistivity with increasing temperature in metallic wires [7]. This effect, known as the Gurzhi effect, was first demonstrated experimentally in a Ga[Al]As heterostructure [8, 9]. Other hallmarks of hydrodynamic transport include the viscous Hall effect [10, 11, 12, 13], superballistic

conduction [14, 15, 16], flow without the Landauer-Sharvin resistance [17], Poiseuille flow in a channel [18, 19, 20, 21, 22], and Stokes flow around obstacles [23, 24]. One of the most remarkable predictions of hydrodynamic theory is the formation of stationary vortices (or whirlpools) [5, 25, 26, 27, 28, 29], which has been indirectly confirmed by negative resistance measurements caused by current backflow [30, 31, 32]. Recently, para-hydrodynamic vortices were shown to exist in WTe $_2$ at cryogenic temperatures through direct imaging [33]. Although transport in this system is described by a hydrodynamic theory, the observed vortices do not originate from electron-electron interactions. Genuine electron-hydrodynamic vortices, although widely anticipated [5, 29], have remained challenging to realize.

Here, we demonstrate direct imaging of stationary current whirlpools in a monolayer graphene (MLG) device at room temperature via scanning nitrogen-vacancy (NV) magnetometry (Fig. 1A). We study the crossover regime from vortex-free to vortex flow (presence of a single whirlpool). We find that the vortex signature is most pronounced in the smallest devices and disappears upon increasing the device size. We observe the whirlpools in both electron and holedominated regimes, but not as the doping approaches charge neutrality. Overall, our measurements are well explained by a hydrodynamic description and clearly rule out a purely diffusive theory.

Imaging of current whirlpools

The collective motion of a viscous electron fluid can be described by the Navier-Stokes equation in conjunction with the continuity equation [3, 18],

$$\vec{J}(\vec{r}) - D_{\nu}^2 \nabla^2 \vec{J}(\vec{r}) + \sigma_0 \nabla \phi(\vec{r}) = 0 , \qquad (1)$$

$$\nabla \cdot \vec{J}(\vec{r}) = 0 \quad . \tag{2}$$

Here, the current density $\vec{J}(\vec{r})$ reflects the flow velocity subject to a potential gradient $\nabla \phi(\vec{r})$ and a viscous term $\nabla^2 \vec{J}(\vec{r})$. D_{ν} is the characteristic length scale describing vorticity diffusion, commonly referred to as the Gurzhi length, and σ_0 is the Drude conductivity [18]. The Gurzhi length can further be related to microscopic scattering theory via [13, 14]:

$$D_{\nu} = \frac{1}{2}\sqrt{l_{\rm ee}l_{\rm mr}} \ . \tag{3}$$

In order to resolve spatial signatures of viscous electron flow, the characteristic size of the device should be similar to or smaller than the Gurzhi length. For high-quality MLG at room temperature, l_{ee} is on the order of 0.2 µm [11, 34] and $l_{mr} \sim 1.0$ µm [35], resulting in an expected D_{ν} on the order of 0.2 µm.

Our MLG device consists of a uniform channel with disc-shaped side pockets (Fig. 1B). For this geometry, the critical length scale is mostly set by the disc opening a [33]. When a is much larger than D_{ν} , the channel current can enter the disc and produce a co-flowing current inside the disc (Fig. 1C). The flow pattern is primarily governed by the potential gradient $\nabla \phi(\vec{r})$ and resembles diffusive transport. By contrast, when the disc opening is similar to or smaller than D_{ν} , the laminar current through the main channel can no longer enter the disc; instead, a counter-flowing vortex current appears mediated by momentum-conserving interactions (Fig. 1D). Therefore, the current direction in the disc – co-flowing or counter-flowing – serves as a hallmark to discriminate between diffusive and hydrodynamic transport.

To map the current distribution in the channel and disc, we image the current-generated magnetic field $\sim 70 \text{ nm}$ above the MLG sheet using a scanning NV magnetometer [36] (Fig. 1A).

We use current amplitudes $I_0 = 2 - 30 \,\mu\text{A}$ that are sufficiently small to not heat the electron gas but still easily detectable by our magnetometer [37]. To further enhance the sensitivity, we modulate the current at $f \sim 25 - 65 \,\text{kHz}$ and synchronize it with a spin-echo detection of the spin sensor's quantum phase [20, 37]. A graphite back gate located $\sim 24 \,\text{nm}$ beneath the graphene flake is used to tune the carrier type (electrons, holes) and concentration between ca. $\pm 2 \cdot 10^{12} \,\text{cm}^{-2}$.

Even deep into the hydrodynamic regime, the vortex current is expected to reach only a few percent of the total current I_0 . To discern the subtle vortex texture from the dominating channel flow, we align the device such that the channel current flows along x while the transverse currents in and out of the disc flow along y. Consequently, we can use the two magnetic field components $B_x \sim +\mu_0 J'_y/2$ and $B_y \sim -\mu_0 J'_x/2$ to obtain separate maps for each current direction. Here, J'_x and J'_y are the low-pass-filtered (due to the NV standoff distance) sheet current densities with units of Am^{-1} ; $\mu_0 = 4\pi \cdot 10^{-7} \text{ T/(Am}^{-1})$. See (38) for a discussion of the current reconstruction.

Figure 2A shows experimental maps of the current flow in the $R = 0.6 \ \mu m$ disc, together with numerical simulations of Eqs. 1 and 2 for the hydrodynamic case (B) and the diffusive case (C), respectively. The sign and shape of the measured J'_y matches the counterflow of the viscous simulation. In addition to the vortex feature in the $R = 0.6 \ \mu m$ disc, the experiment also reproduces the smaller current vortex in the lateral voltage probe and the reduction in J'_x along the channel edges (indicative of Poiseuille flow, see (38)). The hallmark sign of J'_y and the detailed agreement between simulated and experimental maps constitutes the first piece of evidence that transport is governed by electron hydrodynamics in our doped

MLG device.

Transition from viscosity to diffusion-dominated transport

To further support the hydrodynamic model, we image current flow in several discs ($R = 0.6 - 1.5 \ \mu$ m) at a fixed carrier density of $n \approx -1.7 \cdot 10^{12} \text{ cm}^{-2}$, shown in Fig. 3A. Vortices are present up to $R = 1.0 \ \mu$ m, and absent for the largest $R = 1.5 \ \mu$ m disc, indicating the transition out of a viscosity-dominated transport regime. Assuming a device-independent Gurzhi length of $D_{\nu} = 0.28 \ \mu$ m, we accurately reproduce this transition with numerical simulations (Fig. 3B).

The disappearance of the vortex with larger disc size may be explained with an intuitive picture (Fig. 3C): as R increases, so does the disc opening $a \approx R$ (see Fig. 1B). When a is small, the channel current cannot enter the disc because viscosity suppresses the in- and outflowing currents; meanwhile, a vortex is generated in the disc through momentum transfer (left sketch). As a approaches the critical opening $a_{crit} \approx 4.7D_{\nu}$ [33], current starts entering the disc and the vortex fades (middle). Above a_{crit} , the disc current reverses direction and flows as is expected from diffusive transport (right). Because the flow pattern depends on the ratio a/D_{ν} , we can estimate D_{ν} by plotting the normalized transverse current density extracted symmetrically around the disc center as a function of $R \approx a$ (Fig. 3, D and E). Whereas we find excellent agreement for the larger discs, our model underestimates the vortex flow for the smallest disc ($R = 0.6 \ \mu m$). The deviation is likely caused by the assumption of a no-slip boundary condition; refined simulations with a finite slip length and complementary lattice

Boltzmann simulations both predict increased counter-flow for smaller discs (Fig. S13).

Hole and electron carriers

We next turn our attention to the carrier density dependence of the vortex flow. Transport models for graphene predict that both $l_{\rm mr}$ and $l_{\rm ee}$ vary with carrier density [39, 40, 41], thus $D_{\nu} \propto \sqrt{l_{\rm ee}l_{\rm mr}}$ should also depend on n. Figure 4A shows flow patterns for the $R = 0.6 \ \mu m$ disc recorded for hole doping at $n \approx -0.9 \cdot 10^{12} \ {\rm cm}^{-2}$, near the charge neutrality point (CNP), and for electron doping at $n \approx 0.9 \cdot 10^{12} \ {\rm cm}^{-2}$. Vortex flow is observed in both hole-dominated and electron-dominated regimes. Quite strikingly, however, the current backflow disappears near charge neutrality.

For a more quantitative analysis, we record a series of magnetic field maps for varying carrier densities and fit them with numerical simulations to extract values for D_{ν} . Details regarding these simulations, including the implementation of a finite slip length boundary condition [18, 42], are discussed in (38). The resulting values for D_{ν} are plotted as a function of n in Fig. 4C. The data show a strong reduction of D_{ν} near the CNP; D_{ν} is approximately constant away from charge neutrality. Consistent with previous observations [20, 22], we further observe a slight tendency for D_{ν} to decrease for large (hole) doping. Note that around the CNP, the data are still best described by a hydrodynamic model with non-vanishing D_{ν} , as opposed to a fully diffusive model (Fig. S15).

The strong reduction of the Gurzhi length D_{ν} near the CNP, which has also been observed in a previous imaging experiment [43], can be explained by a reduction of the microscopic scattering lengths. In the low-density Fermi liquid regime near the CNP, charged impurity scattering is likely to limit the conductivity in our device ($\sigma_0 \propto n$) [, 39, 44]. Consequently, the mean free path with respect to momentum-relaxing interactions $l_{\rm mr} = \frac{\hbar}{2e^2}\frac{\sigma_0}{\sqrt{\pi n}}$ becomes proportional to \sqrt{n} . Furthermore, $l_{\rm ee}$ scales approximately as \sqrt{n} [11, 32]. One therefore expects D_{ν} to increase with carrier density near charge neutrality. In the ambipolar regime, current-relaxing electron-hole collisions need to be accounted for [45, 46], and more elaborate transport models may be required to describe the electronic transport accurately [47] and to connect the fitted values for D_{ν} to the microscopic scattering lengths.

Curiously, we find that D_{ν} is slightly larger for holes compared to electrons. This carrier asymmetry is also evident by a mildly increased vortex flow for holes in the $R = 0.6 \ \mu m$ disc (Fig. 4A). In addition, we observe an electron-hole inequality in the smallest investigated structure ($R = 0.2 \ \mu m$, Fig. S14). Further evidence for a carrier asymmetry is provided by a fit to the current flow profile along the main channel, which is expected to follow the Poiseuille law. Interestingly, these fits yield D_{ν} values for holes that are almost $2 \times$ smaller compared to the vortex fits (Fig. S4A). By contrast, D_{ν} values for electrons are similar to those extracted from the vortex fits. Such electron-hole asymmetries are not expected from theory and merit further investigation. A possible explanation is a carrier-type-dependent doping at the device edge, which would manifest itself in modified boundary conditions [48].

Discussion and outlook

Our experiments demonstrate that hydrodynamic whirlpools mediated by electron-

electron interactions can be observed in high-mobility materials where $l_{\rm mr} > l_{\rm ee}$. The reversal of the current direction provides a clear spatial hallmark of hydrodynamic transport compared to other signatures such as Poiseuille flow [20]. Additionally, unlike the intermediate temperatures ($T \leq 200$ K) required to observe hydrodynamic flow through a constriction [43], we find clear hydrodynamic signatures at room temperature, likely because of our smaller device geometry.

Although vortex-like features can also emerge in the ballistic regime [29, 33], this is unlikely in our case owing to several reasons: first, to be dominated by ballistic effects, l_{ee} would need to be comparable or larger than the disc diameter, which is $2R \approx 2 \ \mu m$ for the largest disc where we observe a current whirlpool (Fig. 3A). This value is an order of magnitude larger than previously reported $l_{ee} \sim 0.1 - 0.25 \ \mu m$ at room temperature [11, 22]. Second, vortex flow patterns in the ballistic regime, although possible [29, 33], are expected to deviate from those predicted by the hydrodynamic model. Yet, we observe detailed agreement between our experimental data and the hydrodynamic simulation (Fig. 3). Because the transition from the hydrodynamic to the ballistic regime is smooth [19, 29], however, a minor ballistic contribution to the flow pattern cannot be ruled out for the smallest discs ($R \leq 0.6 \ \mu m$).

Further studies will be needed to investigate the nature of boundary scattering in more detail, especially in view of the observed electron-hole asymmetry. Our data suggest that some edge defects may only affect transport for a single carrier type (Fig. S14), potentially because of edge doping [48]. More work is required to gauge whether a simple boundary condition using a single parameter (the slip length l_b) is sufficient to describe these effects. Corresponding experimental studies would benefit from lower temperatures where the slip length is larger [42], or a smaller device size where boundary effects are more prominent. Beyond graphene

monolayers, bilayer graphene (BLG) is a next obvious candidate, as the steeper rise of l_{ee} with carrier density [32, 41], lower viscosity [30], and potentially dominant electron-hole collisions near charge neutrality [45] prominently alter the transport physics. Although BLG has been shown to exhibit a hydrodynamic transport regime [30, 32], it has thus far eluded verification through scanning methods [37]. Finally, an exciting prospect is the imaging of non-linear hydrodynamic effects, such as preturbulence [49, 50] and turbulence [6], which may be possible with NV centers via relaxometry measurements [51, 52].

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Competing interests: The authors have no conflicts to disclose.

Data and materials availability: All data and software are available in the manuscript or the supplementary material or are deposited at Zenodo [53].

Supplementary Materials

Materials and Methods Supplementary Text Figs. S1 to S15 References (54-70)

Figures and Captions

Figure 1: Schematic of the scanning experiment. (A) Configuration of the encapsulated monolayer graphene (hBN-MLG-hBN) device and scanning nitrogen-vacancy magnetometer. (B) Topography (AFM) image of the investigated graphene device. The device consists of a main channel and disc-shaped side pockets of varying radius *R*. The disc opening is approximately $a \approx R$ ($\theta \approx 60^{\circ}$ by design). Bright features are Au contacts. I_0 is the source-drain current. (C) Schematic of current flow in the diffusive regime. (D) In the hydrodynamic regime, current flow inside the disc reverses direction.

Figure 2

Figure 2: **Observation of current whirlpools**. (**A**) Measured channel flow J'_x (top), transverse flow J'_y (middle), and velocity plot of the current density vector \vec{J} (bottom) in the hole-doped regime ($n \approx -1.7 \cdot 10^{12} \text{ cm}^{-2}$). (**B**) Simulation of the same geometry using the hydrodynamic model ($D_v = 0.28 \ \mu\text{m}$). (**C**) Simulation using the diffusive model ($D_v =$ 0.001 μm). Both simulations use a no-slip boundary condition. Simulated maps are low-pass filtered for direct comparison with the experimental J'_x and J'_y maps (38). The dashed lines indicate the device edges. Scale bars are 1 μm . Measurements are at room temperature.

Figure 3

Figure 3: **Disc size determines the transport regime.** (**A** and **B**) Transverse flow J'_y as a function of disc radius R. Upper row shows the experimental data and lower row shows the simulation using $D_v = 0.28 \ \mu m$ with a no-slip boundary condition. All plots are normalized by the device current I_0 . Scale bars are 1 μm . (**C**) Schematic illustrating the transition from vortex flow to vortex-free flow. (**D**) Magnitude of the backflow as a function of disc size and Gurzhi length (numerical simulation). Plotted is the transverse current density J'_y : =

 $[J'_y(-R/2,0) - J'_y(R/2,0)]/2$ at locations $(\pm R/2,0)$ relative to the center of the disc, marked by dots in (A) and (B). The black squares are from the simulations in (B). The horizontal center line corresponds to $D_v = 0.28 \ \mu\text{m}$. The dash-dotted line indicates the critical device size $R_{\text{crit}} \approx a_{\text{crit}}$ where J'_y changes sign. (E) Transverse current density J'_y plotted as a function of R. Red dots are the experimental data extracted from the maps in (A) (error bars are two standard deviations). Curves correspond to simulations using $D_v = 0.28 \ \mu\text{m}$ assuming a no-slip boundary condition (solid black line) and a finite slip length ($l_b = 81 \ \text{nm}$,

blue dashed line), respectively (38). Measurements are at room temperature.

Figure 4

Figure 4: **Carrier dependence of the Gurzhi length.** (**A**) Experimental J'_y flow for hole doping at $n \approx -0.9 \cdot 10^{12} \text{ cm}^{-2}$ (left), near charge neutrality (middle), and for electron doping at $n \approx 0.9 \cdot 10^{12} \text{ cm}^{-2}$ (right) for the $R = 0.6 \mu \text{m}$ disc. Scale bars are 1 μm . (**B**) Schematic representation of the electronic band structure and location of the Fermi energy E_{F}

for the scans shown in (A). (**C**) Gurzhi length D_{ν} as a function of carrier density n. Corresponding plots for the slip length $l_{\rm b}$ and fits of the channel flow profiles are shown in Figs. S3 and S4, respectively. The gray region indicates the ambipolar transport regime ($|E_{\rm F}| \leq 2k_{\rm B}T$, see (38)). The uncertainties of D_{ν} values are around $\pm 0.025 \ \mu$ m, and are dominated by systematic errors caused by an imprecise knowledge of the device geometry, see (38) and Fig. S6. Measurements are at room temperature.









Supplementary Materials for:

Observation of current whirlpools in graphene at room temperature

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MATERIALS AND METHODS

Device fabrication

The encapsulated graphene device is assembled from mechanically-exfoliated graphene and hexagonal boron nitride flakes using a pick-up technique (35, 54). The sample is then annealed in an Ar atmosphere at $350 \,^{\circ}$ C for 3 hours. We define the shape of the contacts via electron beam lithography using a triple-layer resist film of AR-P 632.04, AR-P 672.045, and AR-PC 5090.02, etch away the top hBN layer (CHF₃/O₂ plasma) and create a one-dimensional contact to the graphene sheet through deposition of a Cr/Au (10/50 nm) film and subsequent lift-off (35). Through a secondary electron beam lithography step followed by dry etching, the device geometry is defined (visible through the color change in the stack in Fig. S1). A gold patch was added in a third step to fix a fissure of the graphene sheet next to contact D.

The carrier density in the graphene sheet is tuned via a graphite back gate located $d_{\rm BG} \approx 24 \,\mathrm{nm}$ below the graphene sheet. Assuming a capacitive model with $\epsilon_r \approx 3.76$ (55), we use $n = \epsilon_0 \epsilon_r V_{\rm BG}/(\mathrm{ed}_{\rm BG}) \approx$ $8.7 \cdot 10^{12} \,\mathrm{V}^{-1} \mathrm{cm}^{-2} \cdot V_{\rm BG}$. The associated Fermi energy is $|E_{\rm F}| = \hbar v_{\rm F} \sqrt{\pi |n|}$, where $v_{\rm F}$ is the Fermi velocity and where the sign of $E_{\rm F}$ equals the sign of n. Charge neutrality is typically found near $V_{\rm BG} = 0 \,\mathrm{V}$.

Scanning magnetometer setup

We use commercially available all-diamond scanning probes attached to quartz tuning forks for tip-sample distance control (QZabre). A lock-in amplifier (Zurich Instruments HF2LI) is used to monitor the tuning fork oscillation amplitude and update the target z-position of the sample stage (PI P-527.3CL) using a PID controller. Optical initialization and readout of the NV center is achieved with a confocal microscope (50 μ m pinhole) featuring an objective with a numerical aperture of 0.75 (Mitutoyo M Plan Apo HR 50x). We use a custom-built 520 nm pulsed diode laser for optical excitation of the NV center. The photoluminescence of the NV center is recorded with a single-photon avalanche photodiode (Excelitas SPCM-AQRH). For the manipulation of the NV spin state, microwave pulses are generated using an IQ mixer (Marki MMIQ-0205HSM) where the local oscillator is provided by a microwave synthesizer (NI Quicksyn FSW-0020). The I and Q signals are generated by an arbitrary waveform generator (Spectrum DN2.663-04). The microwave delivery is accomplished using an Al bond wire positioned several tens of micrometers away from NV. The degeneracy of the $m_S = \pm 1$ sublevels of the ground state of the NV center is lifted with a permanent magnet located beneath the sample stage.

During magnetometry operation, we use two analog channels of the arbitrary waveform generator to apply the source-drain voltage V_{SD} and the back-gate voltage V_{BG} synchronously with the pulsed experiments. The resulting device current I_0 is amplified using a transimpedance amplifier (FEMTO DHPCA-100) and monitored with the data acquisition module of a digital lock-in amplifier (Zurich instruments MFLI).

Quantum sensing protocol

We use an AC quantum sensing technique to measure the magnetic field above the sample of interest (20, 37, 56). After initializing the spin state into the $|0\rangle$ state, a $\pi/2$ pulse is applied to create the superposition state $1/\sqrt{2}(|0\rangle + |-1\rangle)$. For a duration $\tau/2$, the spin evolves freely and interacts with the applied magnetic field signal $\vec{B}(t)$. For sufficiently small off-axis fields, the NV is only affected by the component $B_{\rm NV}(t)$ parallel to the symmetry axis of the NV center (57). After this evolution time, the spin state can be written as $|\psi\rangle = 1/\sqrt{2}(|0\rangle + e^{i\phi(\tau/2)}|-1\rangle)$ with $\phi(\tau/2) = \gamma_e \int_0^{\tau/2} B_{\rm NV}(t) dt$ (58). Here, $\gamma_e/(2\pi) = 28.02 \,{\rm GHz/T}$

is the gyromagnetic ratio of the NV electronic spin. A subsequent π pulse effectively reverses the coupling between the spin and the magnetic field (spin echo), and therefore, the total acquired phase after another evolution time of $\tau/2$ is given by $\phi(\tau) = \gamma_e \int_0^{\tau/2} B_{\rm NV}(t) dt - \gamma_e \int_{\tau/2}^{\tau} B_{\rm NV}(t) dt$. For the sinusoidal signals with period $T = \tau$ used throughout this work, this expression evaluates to $\phi(\tau) = \frac{2}{\pi} \gamma_e B_{\rm NV} \tau$. A final $\pi/2$ pulse with a phase Φ relative to the initial microwave pulse converts ϕ into a population difference, and a subsequent optical readout yields a PL signal of the form (37, 59):

$$C_{\Phi} = C_{\text{ref}}^{0} \left(1 - \frac{\epsilon}{2} + \frac{\epsilon e^{-(\tau/T_2)^{\alpha}}}{2} \cos\left(\gamma_{\text{NV}} \frac{\pi}{2} \tau B_{||} + \Phi\right) \right)$$
(S1)

Here, C_{ref}^0 is the PL signal of the $m_S = 0$ state, ϵ is the contrast of the NV center, T_2 is the dephasing time, and α is a free exponent. The phase ϕ is extracted from a set of four measurements ($\Phi \in \{0, \pi/2, \pi, 3\pi/2\}$),

$$\phi = \arctan 2(C_{3\pi/2} - C_{\pi/2}, C_0 - C_{\pi}), \tag{S2}$$

with arctan2 being the two-argument arctangent function, see Refs. (20, 37).

Reconstruction of current density

Reconstruction of the current density is performed in two steps. In a first step, we compute the in-plane $(B_x \text{ and } B_y)$ components of the magnetic field from the measured projection B_{NV} . We carry out the computation in k-space (36, 43, 60),

$$\hat{B}_x = \frac{ik_x \hat{B}_{\rm NV}}{ie_x k_x + ie_y k_y - e_z k} \tag{S3}$$

$$\hat{B}_y = \frac{ik_y B_{\rm NV}}{ie_x k_x + ie_y k_y - e_z k} \tag{S4}$$

where hat symbols denote two-dimensional Fourier transforms, $\vec{k} = (k_x, k_y)$ is the in-plane k-space vector and $k = \sqrt{k_x^2 + k_y^2}$. Further, $\vec{e} = (e_x, e_y, e_z) = (\sin \theta \cos \varphi, \sin \theta \sin \varphi, \cos \theta)$ is the unit vector describing the projection axis and (θ, φ) is the known anisotropy axis of the NV center.

For recovering the current density vector $\vec{J} = (J_x, J_y)$, we note that the stray fields in k-space are given by

$$\hat{B}_x = \frac{1}{2}\mu_0 e^{-kz} \hat{J}_y \tag{S5}$$

$$\hat{B}_y = -\frac{1}{2}\mu_0 e^{-kz} \hat{J}_x$$
 (S6)

where z is the standoff distance. Thus, B_x and B_y are low-pass filtered images of J_y and $-J_x$, respectively (see Fig. S2). The filter convolution function is given by the inverse Fourier transform of e^{-kz} , which has a Lorentzian-like shape,

$$G = \mathcal{F}^{-1}\left[e^{-kz}\right] = \frac{z}{2\pi[x^2 + y^2 + z^2]^{3/2}}$$
(S7)

The J'_x and J'_y maps shown in the main manuscript represent these low-pass filtered maps of J_x and J_y ,

$$J'_{x} = G * J_{x} = -2B_{y}/\mu_{0} \tag{S8}$$

$$J'_{y} = G * J_{y} = 2B_{x}/\mu_{0} \tag{S9}$$

The convolution function has a full width at half maximum of approximately 1.5z, and sets the minimum feature size for the J'_x , J'_y maps. Since the spatial transport features in our experiments are typically larger than 100 nm, the low-pass filtering only has a minor effect on the images. If desired, the spatial resolution could be improved to 0.5 - 1.0z using inverse filtering (36, 60), however, this procedure can introduce image artifacts and thus, we refrained from using it in our analysis unless noted otherwise.

Note that due to a singularity at k = 0, the offsets of J'_x and J'_y are undefined (60, 61). For the J'_y -maps presented in this work, we fix the offset by subtracting the average value of the image. Since the channel of the device is oriented along the x-axis, we expect approximately equal positive and negative contributions to the J'_y image (see Fig. S2). The aforementioned offset calibration is therefore appropriate for this component of the current density. For the J'_x image, an analogous offset correction is not possible and we determine the offset from a region far away from the device.

Simulation of current density maps

For the simulations presented in the main text, we generally assume that variations in the carrier density can be neglected, and that only a single carrier type is present in the device. Furthermore, we neglect the effects of the small magnetic field (few tens of mT) applied to split the $m_S = \pm 1$ sublevels of the NV center, see Supplementary Text 4 for a detailed discussion about the effect of the bias field on the transport. For direct comparison between experimental and simulated data, we compute the low-pass filtered version of the current density (J'_x, J'_y) where necessary.

No-slip boundary condition

For the simulations involving a no-slip boundary condition (18), we solve the partial differential equation describing the electronic transport using the Partial Differential Equation ToolboxTM in MATLAB[®]. We solve Eqs. (1,2) of the main text for (ϕ, J_x, J_y) , where ϕ is the electric potential, by applying suitable Dirichlet boundary conditions for all boundaries. We note that fixing the electric potential on both the source and drain contact results in varying amounts of current flow depending on simulation parameters such as D_{ν} and σ_0 . Where necessary, we rescale the results to reflect the desired amount of current flowing through the device. This is possible due to the linearity of the equation and is equivalent to a change of the source-drain potential. All simulations are performed with a mesh size smaller or equal to 20 nm. For the diffusive case, we set $D_{\nu} = 1$ nm.

General boundary condition

For the experimental determination of the hydrodynamic model parameters, we solve the Navier-Stokes equation using COMSOL Multiphysics[®], similar to Ref. (33). We solve the partial differential equations for the variables (ϕ, J_x, J_y) with a maximal mesh size of 20 nm. For the source and drain contacts, we impose Dirichlet boundary conditions fixing the injected current and the potential, respectively. For the remaining boundaries, we impose a Neumann boundary condition for the current density:

$$-(\vec{n}\cdot\nabla)\vec{J} = -(\vec{n}\cdot\nabla)\vec{J}^{\dagger} - (\vec{n}\cdot\nabla)\vec{J}^{n} = (l_{b}^{t})^{-1}\vec{J}^{\dagger} + (l_{b}^{n})^{-1}\vec{J}^{n}$$
(S10)

Here, the tangential and normal components of the current density are denoted by the superscripts t and n, respectively, where \vec{n} denotes the outward normal vector. We introduce two independent slip length parameters l_b^t and l_b^n for the tangential and the normal component, respectively. By setting $l_b^n = 0.1 \text{ pm}$, we force the normal current density \vec{J}^n to (virtually) vanish at the device edge without forcing its derivative

 $(\vec{n} \cdot \nabla) \vec{J^n}$ to vanish. The remaining tangential part of the boundary condition is identical to the commonly employed boundary condition with variable slip length l_b^t (18, 42):

$$-(\vec{n}\cdot\nabla)\vec{J}^{t} = \left(l_{b}^{t}\right)^{-1}\vec{J}^{t}$$
(S11)

Estimation of D_{ν} , $l_{\rm b}$ and z from the vortex flow

We extract estimates for the vorticity diffusion length D_{ν} , slip length $l_{\rm b} := l_b^t$ and standoff z by comparing the experimental data to simulations based on the Navier-Stokes equation. For a discrete set of parameters $(D_{\nu} \in [10 \text{ nm}; 400 \text{ nm}]$ in steps of 10 nm (up to 500 nm for the R = 0.6 um disc); $l_b \in [1 \text{ nm}; 193 \text{ nm}]$ in steps of 8 nm), we simulate maps of the current density using COMSOL Multiphysics[®] and compute the corresponding magnetic field maps according to Ref. (60), accounting for a 1° rotation of the sample with respect to the scan axes. We generate magnetic field maps for standoff distances between 50 nm and 120 nm in steps of 2 nm. For the computation of the magnetic field projection $B_{\rm NV}$, we use the NV angles $(\theta \approx 55^{\circ}, \varphi \approx 1^{\circ})$.

For the data shown in Fig. 4C of the main text, we estimate the Gurzhi length and the slip length of the experimental data by fitting the maps of the normalized magnetic field derivative $\Gamma_x = \frac{1}{I_0} \frac{\Delta B_{\text{NV}}}{\Delta x}$ to the hydrodynamic model via nonlinear least squares. We compare Γ_x rather than B_{NV} , since the spatial derivative allows us to disentangle the disc flow more easily from the channel flow (see Fig. S2). Furthermore, the derivative conveniently removes long-range magnetic field signals originating from current flow in nearby metallic leads. Note that we compare solely the pixels in a circular area with radius $R + 0.1 \,\mu\text{m}$ around the disc center (see Fig. S3 (C)). This ensures that the parameter estimation is based on the signatures from the whirlpool and is not affected by imperfections in the channel that are not accounted for by the model. We use cubic interpolation to generate maps of Γ_x for fit parameters not covered by our discrete set of simulations. The results of this fitting procedure are shown in Fig. S3 (A-B) for a fixed standoff distance $z = 72 \,\text{nm}$ (see next paragraph). Estimates for the standard deviations of the fit parameters are obtained from the covariance matrix returned by the fit. Experimental data and the corresponding simulations are presented in Fig. S3 (G-J) for a measurement on the 0.6 μ m disc.

For the data shown in the main text and in Fig. S3 (A-B), we assume a standoff distance of z = 72 nm, based on the fitting results from the channel flow (Fig. S4 (C)). Note that for our discrete set of simulations, the maps computed for z = 72 nm approximate $z_{\text{fit}} \approx 73 \text{ nm}$ the best. When additionally fitting for the standoff distance z (Fig. S3 (D-F)), the results are qualitatively similar. However, we also observe a weak correlation between the fitted standoff z and the disc radius R in this case. Since all scans were acquired with the same scanning probe, a large change of z is not expected (see also Fig. S5 for the time evolution of z extracted from the channel fit). Therefore, we believe that this correlation is nonphysical and an artifact of the fitting.

Estimation of D_{ν} , $l_{\rm b}$ and z from the channel flow

We further analyze the flow profile through the main channel, which is expected to show a gradual reduction of J_x to zero near the device edges (Poiseuille flow, c.f. supplementary text 2). Rather than fitting the onedimensional profile by an analytical function (20), we apply the above minimization to a two-dimensional channel region, as indicated in Fig. S4. For the channel fitting, we minimize the magnetic field derivative $\Gamma_y = \frac{1}{I_0} \frac{\Delta B_{\text{NV}}}{\Delta y}$ rather than Γ_x . Fig. S4 (A-C) summarizes the results of this analysis. Interestingly, we find $\approx 2 \times$ smaller values for D_{ν} on the hole side compared to the disc fitting. Also, the suppression of D_{ν} near the CNP is much less pronounced. Entering the parameters obtained from the channel fit of a $R = 0.6 \ \mu \text{m}$ disc measurement into a simulation of the disc flow, we find that the vortex features are not well reproduced, see *e.g.* Fig. S4 (D, F). Thus, a single D_{ν} value cannot simultaneously and correctly reproduce the vortex and Poiseuille flow profiles. This points towards a systematic deviation of the observed flow from a purely hydrodynamic (Navier-Stokes) model with rigid boundary conditions.

Systematic error in D_{ν} due to variations in the device geometry

To assess whether this discrepancy could be explained by a mismatch between the simulated and the lithographically-defined device geometry, we generate current density maps for 3 additional device layouts of the $R = 0.8 \ \mu\text{m}$ disc (see Fig. S6). As a first test, we study a slightly larger geometry (G1) with $W = 1.05 \ \mu\text{m}$ and $R = 0.825 \ \mu\text{m}$ and an opening angle of 60 deg. This error could be caused, for example, by a slight calibration offset between the commercial AFM used to record the height map that forms the basis for simulations, and the scanning stage of the scanning NV magnetometer. In a second geometry (G2), we keep the channel width and the disc radius constant but increase the opening gap to $a = 0.85 \ \mu\text{m}$. Such an modification is expected, for example, if the spatial resolution of the patterning process is insufficient to properly define the sharp corners. Finally, we mimic the case of an overexposure during the e-beam lithography process with geometry G3. For this simulation, we shift the device boundaries inward by 25 nm while keeping disc center at the original location. Note that we keep the opening gap fixed $a = 0.8 \ \mu\text{m}$ for this study.

As illustrated in Fig. S6(C-H), we find that the above variations in the simulated geometry lead to systematic errors in all three fit parameters. The changes in the extracted D_{ν} values are approximately $\pm 0.025 \ \mu m$, and exceed the fit errors from the least squares minimization, which are of order $\pm 0.01 \ \mu m$. Therefore, we conclude that the accuracy of D_{ν} is dominated by systematic errors related to incomplete knowledge of the device geometry, and not by statistical fit errors. Since a systematic error shifts all D_{ν} values in Fig. 4C in the same direction, neither the electron-hole asymmetry nor the pronounced dip near the CNP are affected. Furthermore, the discrepancies on the hole side between the vortex and channel fits are not eliminated.

Alignment of the device boundary

To compare experimental with simulated magnetic field maps, we need to accurately determine the physical coordinates of the device with respect to the simulation. Our two reference coordinates are the y coordinate of the horizontal symmetry axis of the channel (y_C) and the x coordinate of the vertical symmetry axis of the circle (x_C) .

We have implemented two strategies for determining y_C . A first approach (used for Fig. 3, Fig. S7, S14, and Supplemental Text 5) consists in finding the y-coordinates along vertical line cuts where $B_{\rm NV}$ is closest to zero in the channel. The highest occurrence is then determined to be y_C (see Fig. S7 (A)). A second approach, used for the parameter estimation described in the Methods, consists in finding the maxima and minima of $B_{\rm NV}$ along vertical line cuts. After fitting the coordinates of the maxima and minima with linear functions, y_C is set to the half-way point between the maximum and minimum locations. For the estimation of x_C , we analyze the reconstructed B_x image (Fig. S7 (B)). The maximum and minimum of the laminar channel flow (marked as yellow dots) should be located symmetrically around the center of the disc. An estimate for x_C is found by averaging the x-coordinates of the two extreme values.

The alignment can also be validated by plotting the estimated device boundaries together with the NV photo-

luminescence (PL) image recorded simultaneously with the magnetic field map (Fig. S7 (C)). The NV PL map is expected to reflect the device geometry accurately, however, it is less quantitative than the magnetic estimation above. The physical device edges indicated in Fig 4A, Fig. S9, S10, and S11 are determined directly from the PL maps.

Current monitoring normalization

We monitor the device current by recording a sample I(t) of the source-drain current at each pixel, see Fig. S8. The amplitude I_0 is determined as one-half the peak-to-peak amplitude of I(t). When comparing current flow patterns, we typically normalize the magnetic field maps by I_0 .

Measurement parameters for Figs. 2-4

Fig. 2A used the following parameters: $n \approx -1.7 \cdot 10^{12} \,\mathrm{cm}^{-2}$ ($V_{\mathrm{BG}} = -2 \,\mathrm{V}$), $I_0 = 28.7 \,\mu\mathrm{A}$. $\theta = 56^\circ$, $\varphi = 1^\circ$ (Scanning probe NV1). For the streamlines, we reconstruct the current density with $z = 75 \,\mathrm{nm}$ and $\lambda = 1.5 \cdot z$.

Fig. 3A used the following experimental parameters: $n \approx -1.7 \cdot 10^{12} \text{ cm}^{-2}$ ($V_{\text{BG}} = -2 \text{ V}$), $I_0 = \{15.7, 15.7, 15.5, 15.4\} \mu \text{A}$ from left to right. $\theta = 55^{\circ}, \varphi = 1^{\circ}$ (Scanning probe NV2).

Fig. 3B used the following simulation parameters: $D_{\nu} = 0.28 \ \mu \text{m}, z = 110 \ \text{nm}.$

Fig. 4A used the following parameters: $n \approx \{-0.9, 0, +0.9\} \cdot 10^{12} \text{ cm}^{-2}$ ($V_{BG} = \{-1, 0, +1\}$ V) from left to right, $I_0 = \{24.3, 8.7, 24.3\}$ μ A from left to right. $\theta = 56^{\circ}$, $\varphi = 1^{\circ}$ (Scanning probe NV1).

Fig. 4C used $n \approx (-1.9...1.7) \cdot 10^{12} \text{ cm}^{-2}$ corresponding to $V_{BG} = (-2.2...+2) \text{ V}$, $I_0 = 2-15 \mu \text{A}$. All measurements were acquired with scanning probe NV2. We fit the experimental data assuming z = 72 nm.

SUPPLEMENTARY TEXT 1: NON-LINEARITY NEAR CHARGE NEUTRALITY

In the vicinity of the CNP, we often observe an asymmetry in the recorded current trace for a symmetrically applied AC source-drain voltage (Fig. S9 (A)). This could be an indication that the local carrier density is not fixed during the AC magnetometry protocol. Since we apply source-drain voltages on the order of 100 mV to overcome the large two-terminal resistance at the CNP (~ 25 kOhm) and generate a detectable source-drain current, the electrostatic potential at the measurement location is also expected to change. Indeed, measurements of the longitudinal resistance between contacts C and D (comprising the Au patch, Fig. S1) confirm that the local V_{CNP} changes as a function of the applied bias voltage (Fig. S9 (B)).

To exclude that the fading of the vortex feature close to charge neutrality is an artifact of a carrier density modulation, we image the $R = 0.8 \ \mu m$ disc using a complementary DC technique. For this purpose, we conduct a Ramsey-type experiment at $V_{\rm SD} = 0.2 \ V$ with $\tau = 16 \cdot 2\pi/A_g^{||} \approx 5.27 \ \mu s$. Here, $A_g^{||} \approx 2\pi \cdot 3.03 \ MHz$ is the parallel hyperfine coupling of the NV center. For this particular choice of the evolution time τ , the polarization of the ¹⁵N nuclear spin forming the NV center does not affect the measurement result and a simple PL signal of the form of Eq. S1 is recovered. We take measurements near charge neutrality ($V_{\rm BG} = 0.1 \ V$) and far away ($V_{\rm BG} = 2 \ V$) using a differential scheme (signal on/off). The resulting J'_y maps are shown in Fig. S9 (C-D) for a DC current flowing in negative x direction. This experiment confirms that the vortex feature indeed disappears near charge neutrality.

SUPPLEMENTARY TEXT 2: POISEUILLE FLOW

We also analyze the channel flow profile, which should turn from rectangular to parabolic as the transport changes from diffusive to hydrodynamic. This spatial signature is known as Poiseuille flow, and has been analyzed in previous spatial imaging experiments (19, 20). In the limit where the current density vanishes completely at the device boundaries (no-slip), the current profile is given by (18):

$$J_x = \frac{\sigma_0}{e} \nabla \phi \left[1 - \frac{\cosh \frac{y - y_0}{D_\nu}}{\cosh \frac{w}{2D_\nu}} \right]$$
(S12)

In the extreme case where D_{ν} is large compared to the width w of the channel (and $l_{ee} \ll w$), the current profile can be described approximately by a parabola. Ref. (20) observed such behavior in room-temperature monolayer graphene and reported $D_{\nu} \gtrsim 0.3 \ \mu m$ for their devices. Given the estimate for the Gurzhi length in our device (see Figs. S3, S4), we would expect to observe a non-uniform channel profile at the very least away from the CNP, *i.e.*, for $|n| \gtrsim 0.5 \cdot 10^{12} \,\mathrm{cm}^{-2}$.

Fig. S10 shows maps of the current density in the $R = 0.6 \ \mu \text{m}$ disc at $V_{\text{BG}} = -2 \text{ V} \ (n \approx -1.7 \cdot 10^{12} \text{ cm}^{-2})$ (A-B), and at $V_{\text{BG}} = 0 \text{ V}$ (C-D). These maps were recorded using the Ramsey protocol to prevent a modulation of the carrier density during data acquisition (see Supplementary Text 1). Again, we observe a current vortex only away from charge neutrality. Line cuts of the normalized magnetic field B_{NV}/I_0 and current density J_x/I_0 are shown in Fig. S10 (E-F). We notice that B_{NV} barely differs between the two images. Fortunately, the reconstructed current density is more instructive. The channel profile at hole doping is indeed more parabolic than at charge neutrality. While this observation is consistent with our previous findings, the differences are less striking than the presence or absence of a current vortex. This is to be expected, because the channel profile becomes gradually flatter in the center upon decreasing D_{ν} and does not display a hallmark sign change like the vortex maps. Therefore, we find the whirlpools to be better suited for studying electron hydrodynamics in our device than the Poiseuille flow.

SUPPLEMENTARY TEXT 3: ELECTRIC FIELD IMAGING

Fig. S11 (A-B) displays the numerically computed derivative of a measured AC magnetic field map acquired using the protocol described in the Methods section, together with a corresponding image obtained using the scanning gradiometry technique (62). Both measurements are taken at $n \approx -1.7 \cdot 10^{12} \text{ cm}^{-2}$. As expected, the vortex appears in both images. However, the gradiometry technique picks up an additional signal above the etched region of the vdW stack where the back gate is not screened by the graphene sheet. We attribute this signal to the static electric field generated by the back-gate potential. Such static electric fields are only visible in a dynamic imaging mode (oscillating tuning fork) because they are otherwise screened by mobile charges on the diamond tip (63, 64).

To confirm the electrical origin of this signal, we image the sample again using an AC sensing technique (Hahn echo). However, instead of modulating the device current, we modulate the back-gate voltage $V_{\rm BG}$. A map of the resulting electric-field-induced frequency shift and its derivative along x are shown in Fig. S11 (C-D). These maps clearly show the presence of an electric field above the etched part of the device. Furthermore, the features observed in the gradiometry scan are qualitatively well explained by the electric field gradient.

SUPPLEMENTARY TEXT 4: EFFECT OF AN OUT-OF-PLANE MAGNETIC FIELD

Current flow in the hydrodynamic model, subject to an out-of-plane magnetic field B_z , is described by the linearized Navier-Stokes equation and the continuity equation (10, 13):

$$\vec{J}(\vec{r}) - D_{\nu}^{2} \nabla^{2} \vec{J}(\vec{r}) + \omega_{c} \tau (1 + D_{\rm H}^{2} \nabla^{2}) \vec{J}(\vec{r}) \times \vec{e_{z}} + \sigma_{0} \nabla \phi(\vec{r}) = 0$$
(S13)

$$\nabla \cdot \vec{J}(\vec{r}) = 0 \tag{S14}$$

In this equation, $\omega_c = \operatorname{sgn}(n) \frac{eB_z}{m^*}$ is the cyclotron frequency, τ is the mean free time with respect to momentum-relaxing scattering events, and m^* is the cyclotron mass. We include the signum function $\operatorname{sgn}(n)$ to reproduce the correct sign dependence for electrons (n > 0) and holes (n < 0). $D_{\rm H}$ is a diffusion constant related to the Hall viscosity $\nu_{\rm H}$ (10, 13).

In a typical scanning NV magnetometry experiment, applied magnetic fields do not exceed a few tens of mT and expected values for the diffusion length $D_{\rm H}$ are $< 1 \ \mu {\rm m}$ for monolayer graphene at room temperature (10). While a perpendicular magnetic field does affect the potential landscape, it does not significantly change the current profile in the Hall-bar geometry. As shown in Fig. S12, the current density distribution is only modified near the source and drain contacts, but not in the imaging region near the discs. Therefore, we neglect the pertinent terms in the equations of the main text and the associated simulations.

SUPPLEMENTARY TEXT 5: RELATIVISTIC LATTICE BOLTZMANN SIMULATIONS

We employ the relativistic lattice Boltzmann method (RLBM) to model two-dimensional (2D) singleparticle flow away from the hydrodynamic and diffusive limits, shown with Fig. S13. Our RLBM framework is based on the D2V72 quadrature scheme (65) in the ultra-relativistic limit (66). RLBM simulations discretize the energy and momentum phase space of the quasi-particle distribution function f into a set of 72 quadrature components. These quadratures are combinations of six energies and twelve isotropic momenta vectors in 2D. f is uniquely defined at every lattice point and lattice points are placed on a square grid to approximate any simulation geometry in real space. The governing equation is given by:

$$p^{\mu}\partial_{\mu}f = \frac{p_{\mu}U^{\mu}}{v_{\rm F}^2}\Omega[f] , \qquad (S15)$$

where $p^{\mu} = |p|[1, \frac{v_x}{v_F}, \frac{v_y}{v_F}]$ is the quasi-particle momentum, $U^{\mu} = \gamma[v_F, u_x, u_y]$ is the macroscopic velocity, $\gamma = (1 - \mathbf{u} \cdot \mathbf{u}/v_F^2)^{-1/2}$ is the Lorentz factor, and $\partial^{\mu} = [\frac{\partial_t}{v_F}, -\partial_x, -\partial_y]$ is the gradient operator, shown in contravariant form using the (+, -, -) metric signature. $\mathbf{u} = [\mathbf{u}_x, \mathbf{u}_y]$ and $\mathbf{v} = [\mathbf{v}_x, \mathbf{v}_y]$ are the macroscopic (belonging to the lattice point) and microscopic (belonging to the individual quadrature) two-component velocities, respectively. $v_F \sim 10^6 \text{ m/s}$ is the Fermi velocity (analogous to the speed of light in special relativity), and Ω is the collision operator, defined below. It is convenient to convert Eq. S15 into the following version of the RLBM equation:

$$\frac{\partial f}{\partial t} + \mathbf{v} \cdot \nabla f = \eta \Omega[f] , \qquad (S16)$$

as it closely resembles the classical LBM equation with one addition prefactor term, $\eta = \gamma \left(1 - \mathbf{v} \cdot \mathbf{u}/v_{\mathrm{F}}^2\right)$, that captures relativistic effects. The left- and right-hand sides of Eq. S16 represent the streaming and collision steps of the simulation, respectively. In the streaming step, the quadratures are propagated outward from their respective lattice point according to their momenta and are collected by neighboring lattice points. Bilinear interpolation is used to collect streamed quadrature components that end up between neighboring lattice points (65). In the collision step, the collected quadrature components are redistributed by the collision operator according to their energy and momentum. The RLBM framework alternates between streaming and collision steps to iteratively approach a steady-state distribution across all lattice points.

The collision operator includes both momentum-conserving and relaxing terms to account for the carriercarrier scattering and carrier-phonon/impurity scattering. Specifically, we set

$$\Omega[f_k] = \frac{f_k^{ee} - f_k}{\tau_{ee}} + \frac{f_k^{mr} - f_k}{\tau_{mr}} = \frac{f_k^{ee}}{\tau_{ee}} + \frac{f_k^{mr}}{\tau_{mr}} - \frac{f_k}{\tau_{eff}} , \qquad (S17)$$

where the subscript k refers to the 72 quadrature components, f_k^{ee} comes from evaluating the Fermi-Dirac equilibrium distribution function (using the BGK approximation (67)) and f_k^{mr} isotropically redistributes the momentum at every lattice point via energy-conserving collisions (68). It can be explicitly written as

$$f_k^{mr} = \frac{\sum_i \delta_{\varepsilon_k, \varepsilon_i} f_i}{\sum_i \delta_{\varepsilon_k, \varepsilon_i}} , \qquad (S18)$$

where δ is the Kronecker delta function and ε_k is the energy of the k^{th} quadrature. The f_k/τ_{eff} term ensures quasi-particle conservation. The simulation-wide time constants directly relate to the macroscopic scattering length scales through $\tau_{\text{ee}} = l_{ee}/v_{\text{F}}$, $\tau_{\text{mr}} = l_{mr}/v_{\text{F}}$, with $\tau_{\text{eff}}^{-1} = \tau_{\text{ee}}^{-1} + \tau_{\text{mr}}^{-1}$. Thus, τ_{ee} and τ_{mr} act as user-controlled values that steer the RLBM simulation towards a more hydrodynamic or diffusive behavior. Ballistic effects, while not directly accounted for, naturally arise as characteristic device sizes decrease relative to all scattering lengths. We note that simulation artifacts may arise if ballistic effects dominate (*e.g.*, in the deep ballistic regime).

We describe scattering off device edges via one of three redistribution methods. Bounce-back scattering (69), where momentum is inverted, is used to mimic a zero-slip-length boundary condition as it ensures zero velocity on the edges. Specular scattering (9), which reflects perpendicular components of momenta, and diffusive scattering (70), which redistributes momenta accounting for energy and density conservation, mimic a more general boundary condition with non-zero slip length.

To set the device current, we apply Neumann boundary conditions (a constant, uniform flux of current density) at the source and drain contact of the simulated device. No additional forcing term was applied. A given simulation iterates until subsequent iterations show an average absolute change in macroscopic velocity across all lattice points that is below a convergence threshold, typically of order 10^{-6} . Other simulation details include a lattice grid size of 25 nm, T = 300 K and no chemical doping.

To determine the macroscopic current density, we first compute the energy-momentum tensor $T^{\mu\nu}$ at every lattice point (65),

$$T^{\mu\nu} = \sum_{k} f_k p_k^{\mu} p_k^{\nu} \,. \tag{S19}$$

Then, we solve the eigenequation $T^{\mu}_{\nu}U^{\nu} = \varepsilon U^{\mu}$ numerically (via the power method) for the macroscopic energy density eigenvalue ε and the macroscopic velocity eigenvector U^{μ} . From the macroscopic velocity, the quasi-particle density can then be computed with $\rho = \sum_{k} U_{\mu} p^{\mu}_{k} f_{k} = v_{\rm F} \sum_{k} f_{k} |p_{k}| \eta_{k}$. Finally the current density J can be obtained by combining the charge q, density ρ , and macroscopic two-component velocity u:

$$\mathbf{J} = q\rho\mathbf{u} = qv_{\rm F}\sum_k f_k |p_k| \eta_k \mathbf{u} .$$
(S20)



FIG. S1. **Optical microscope image of the whirlpool device.** We send a current through contacts A and B, and use contacts C and D for monitoring the longitudinal voltage drop. The carrier density in the graphene sheet can be tuned via contact E. The unlabeled contact is not connected.



FIG. S2. Illustration of the different reconstruction methods and analysis tools used for the investigation of current whirlpools. The data shown in this figure are simulated. Starting from the quantum phase (A) as obtained from the Hahnecho protocol, we first extract the encoded magnetic field map $B_{\rm NV}$ (B) by unwrapping the phase map and using the relation $\phi = \frac{2}{\pi} \gamma_e B_{\rm NV} \tau$. We can then reconstruct the current density $J'_x = -\frac{2}{\mu_0} B_y$ and $J'_y = \frac{2}{\mu_0} B_x$ (C and D) using the known NV angles $\theta = 55.7^\circ$, $\varphi = 1^\circ$. Alternatively, we can apply inverse filtering (36, 60) to trade signal-to-noise ratio for a slightly improved spatial resolution (J_x and J_y in E and F) using a Hann filter (here with $\lambda = 100$ nm); however, this inverse filtering was not necessary for most of the data shown in this work. Finally, the signatures from the current flow of the disc can also be disentangled from the channel flow by computing the magnetic field derivatives $\frac{\Delta B_{\rm NV}}{\Delta y}$ (G) and $\frac{\Delta B_{\rm NV}}{\Delta x}$ (H). Via a subsequent computation of $-\frac{\Delta B_z}{\Delta x}$ (I) involving the NV angles, a map reminiscent of J_y can be obtained.



FIG. S3. Parameter fits to vortex flow. (A and B) Carrier density dependence of D_{ν} and l_b obtained by fitting $\Gamma_x = \frac{1}{I_0} \frac{\Delta B_{NV}}{\Delta x}$ for several scans on three separate discs. The standoff distance is fixed at z = 72 nm. The fit areas are indicated in C. Error bars represent one standard deviation. (D-F) Fit results obtained by optimizing also with respect to the standoff distance z. (G and H) Experimental data (Γ_x , Γ_y computed from B_{NV}) taken at $n \approx 0.9 \cdot 10^{12} \text{ cm}^{-2}$ ($V_{BG} = 1 \text{ V}$) and (I and J) simulated maps with (D_{ν} , l_b , z = 72 nm) chosen as close as possible to the fitted parameters. The fit area is indicated by the blue dashed line.



FIG. S4. Parameter fits to channel flow. (A-C) Carrier density dependence of D_{ν} , l_b , and z obtained by fitting $\Gamma_y = \frac{1}{I_0} \frac{\Delta B_{\rm NV}}{\Delta y}$ at three different location above the channel (see inset in **B** for the fit areas). The mean fitted standoff distance is ≈ 73 nm. Error bars represent one standard deviation. (**D** and **E**) Experimental data (Γ_x , Γ_y) taken at $n \approx 0.9 \cdot 10^{12}$ cm⁻² ($V_{\rm BG} = 1$ V) for the $R = 0.6 \ \mu m$ disc (same as Fig. S3 (**G** and **H**)). The corresponding simulations with (D_{ν} , l_b , z) chosen as close as possible to the fitted parameters are shown in **F** and **G**. The fit area is indicated by the blue dashed line.





FIG. S6. Estimation of the systematic fit errors for the $R = 0.8 \ \mu m$ disc. (A) Height map of the $R = 0.8 \ \mu m$ disc acquired with a commercial AFM. The outline of the simulated geometry is indicated by the orange dashed line. (B) Schematic of the different device geometries which are analyzed for estimating the impact of imperfections in the physical device geometry. The orange line represents the geometry as defined in the layout software. G1 represents a slightly larger device with $W = 1.05 \ \mu m$ and $R = a = 0.825 \ \mu m$. G2 is identical to DG except that the opening gap a is increased by 50 nm. G3 uses $W = 0.95 \ \mu m$, $R = 0.775 \ \mu m$ and $a = 0.8 \ \mu m$. (C-E) D_{ν} , l_b , and z as a function of the carrier density n for the channel data. The fit area is indicated in Fig. S4. (F-H) D_{ν} , l_b , and z for the disc data (see Fig. S3 for the fit area). The dashed lines in C, F serve as a guide to the eye.



FIG. S7. Illustration of the device boundary alignment procedure. (A) $B_{\rm NV}$ map for determining the horizontal symmetry axis of the channel (y_C). (B) B_x map for determining the vertical symmetry axis of the circle (x_C). (C) NV PL map for validating the boundary alignment. (D) Representation of the mask of the scan used for distinguishing between the scan boundary (black, two pixels), the relevant device region (orange) and the background region (white). The dark (light) gray line corresponds to the boundary of the inner (outer) graphene sheet. The gap is defined via reactive ion etching and has a width of ~ 0.2 μ m. Scale bars are 1.0 μ m



FIG. S8. Extraction of the current amplitude from experimental data. The current signal I(t) is recorded at each pixel (colored traces). The current amplitude I_0 , defined as half of the peak-to-peak current signal, is then extracted from the average over all traces (black). The sharp peaks (indicated by arrows) are due to a modulation of the back-gate voltage. Since they occur outside the phase accumulation window of the quantum sensor, they do not influence the magnetometry signal. Four repetitions are shown, corresponding to the four readout phases of the sensing protocol.



FIG. S9. Imaging near charge neutrality. (A) Asymmetry in the current trace of a scan recorded at $V_{BG} = 0.3 \text{ V}$ and $V_{SD} = 0.2 \text{ V}$. (B) Longitudinal resistance measured between contacts C and D as a function of the back-gate voltage for different source-drain biases. A small AC modulation ($V_{AC} = 5 \text{ mV}$) is added on top of the bias voltage for lock-in detection. (C) DC map of J'_y acquired close to the CNP for a source-drain voltage of $V_{SD} = 0.2 \text{ V}$. (D) Map of J'_y acquired away from charge neutrality. For this image, the averaging time per pixel has been reduced to yield approximately the same SNR as the image shown in (C). Scale bars are 1 μ m.



FIG. S10. Simultaneous DC imaging of current vortices and channel profiles. (A and B) Maps of the current density components J_x and J_y at $V_{BG} = -2 V$ ($n \approx -1.7 \cdot 10^{12} \text{ cm}^{-2}$). Measurements use a Ramsey protocol with a phase accumulation time of $\tau = 11.8 \ \mu\text{s}$. For the reconstruction, we assume a standoff distance of z = 72 nm (estimated based on the fitting results for the channel) and use $\lambda = 1.5 \cdot z$. The device geometry is indicated with dashed lines (estimated from PL maps). (C and D) Corresponding maps for $V_{BG} = 0 V$. The black line indicates the location of the line cuts analyzed in E and F. Scale bars are 1 μ m. (E) Comparison of the magnetic field line scans across the channel. The data sets are normalized by the device current I_0 . Error bars represent one standard deviation, extracted from the shot noise in the measurement signal (37). (F) Reconstructed current density profiles. The shaded area represents one standard deviation. This uncertainty is extracted from a region without signal next to the channel.



FIG. S11. Imaging of the magnetic and electric field over the $R = 0.6 \ \mu m$ disc. (A) Map of $\Delta B_{\rm NV}/\Delta x$ derived from an AC measurement at $n \approx -1.7 \cdot 10^{12} \, {\rm cm}^{-2}$. (B) Image of the same region recorded using the gradiometry technique. An additional gradient signal $\Delta \Pi/\Delta x$ is picked up, most prominently at the device edge. (C) Map of the shift f_E of the NV resonance frequency caused by the electric field from the back gate. An AC detection scheme is used for this measurement. (D) Spatial derivative along x of the map shown in (C). This map is low-pass filtered in Fourier space using a Hann filter with a cutoff frequency at $2\pi/(100 \, {\rm nm})$. The dashed lines indicate the physical edge of the device and have been determined from PL maps. Scale bars are 1 μm .



FIG. S12. Simulations of the electric potential ϕ and current density components J_x , J_y in a perpendicular magnetic field. (A-C) Solutions of the Navier-Stokes equation in zero-field. (D-F) Simulation results for an out-of-plane magnetic field of $B_z = 20 \text{ mT}$. (G-I) Simulation results at $B_z = 20 \text{ mT}$ and assuming $D_{\rm H} = 1 \mu \text{m}$. For all simulations, we assume $n = 10^{12} \text{ cm}^{-2}$, $D_{\nu} = 0.25 \mu \text{m}$ and $\mu = e\tau/m^* = 2.64 \cdot 10^4 \text{ cm}^2/\text{Vs}$.



FIG. S13. Disc simulations beyond the no-slip Navier-Stokes simulation and for the Lattice-Boltzmann method. (A and **B**) Normalized low-pass filtered current density J'_y/I_0 (A) and true current density J_y/I_0 (B) obtained from lattice Boltzmann simulations with different boundary conditions. (C and D) Normalized low-pass filtered current density J'_y/I_0 (C) and true current density J_y/I_0 (D) obtained from Navier-Stokes simulations with different slip lengths. In all panels, the no-slip data (shown with red circles) is the Navier-Stokes simulation curve shown in Fig. 3E of the main text and the black dots are the corresponding data points. (E) J'_y/I_0 for a no-slip boundary condition and varying D_{ν} .



FIG. S14. Observed asymmetries between electron and hole doping. (A) Asymmetry in the vortex flow for the 0.2 μ m disc. The signature in the channel is much less pronounced for the scan at $V_{BG} = -2 V$ ($n \approx -1.7 \cdot 10^{12} \text{ cm}^{-2}$). For these measurements, we use a dynamic decoupling sequence with 8 refocusing pulses and a phase accumulation time of $\tau = 55 \mu$ s. (B) Carrier-type dependent scattering at the device edge for scans on the $R = 1.0 \mu$ m disc. The arrow indicates the location where the asymmetry occurs.



FIG. S15. Demonstration that the Gurzhi length is non-zero even at charge neutrality. Plots show the measured data $(V_{BG} = 0 \text{ V})$ together with the corresponding simulations of the Navier-Stokes equation assuming different values for D_{ν} . A no-slip boundary condition is assumed for all simulations.